Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
10/564,152	NISHINO, HISANORI
Examiner	Art Unit
David E. Bochna	3679

	SEARCHED			
Class	Subclass	Date	Examiner	
285	133.3	1/2/2008	DB	
	133.5			
	133.6			
	133.11		- *	
	133.21			
	133.4			

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